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High performance quantum cascade lasers based on three-phonon-resonance design

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A quantum cascade laser structure based on three-phonon-resonance design is proposed and demonstrated. Devices, emitting at a wavelength of 9 μm, processed into buried ridge waveguide structures with a 3 mm long, 16 μm wide cavity and a high-reflection (HR) coating have shown peak output powers of 1.2 W, slope efficiencies of 1 W/A, threshold current densities of 1.1 kA/cm², and high wall-plug efficiency of 6% at 300 K. A 3 mm long, 12 μm wide-buried-heterostructure device without a HR coating exhibited continuous wave output power of as high as 65 mW from a single facet at 300 K. © 2009 American Institute of Physics.

Quantum cascade lasers (QCLs) can be designed and fabricated to cover the whole midinfrared range (3–25 μm), which is important for gas analysis and chemical sensing, industrial process monitoring, free-space communication, and military applications. Due to their small footprint, their high performance at room temperature (RT), and the possibility to easily tailor their emission wavelength, QCLs are the most convenient light sources in the midinfrared. QCLs with state-of-the-art performance can be grown using either molecular beam epitaxy (MBE) or metal organic vapor phase epitaxy (MOVPE).

Since the invention of QCLs in 1994, tremendous progress has been made to improve the performance of QCLs, leading to the demonstration of continuous wave (cw) output powers exceeding 1 W at 4.6 μm,2,3 200 mW at 8 μm,4 and 100 mW at 10 μm (Ref. 5) at RT. These were achieved by rapid advances in material growth, processing technology, waveguide design and packaging, and last but not least by constant improvements in the band-structure design of the QCL gain medium. Because of the huge parameter space available in the band-structure design, a wide variety of designs has been demonstrated, including, for example, active regions based on a two-phonon resonance,5–7 on a bound-to-continuum design,7 on a chirped superlattice,8 and on a single-phonon-continuum design.9

To ensure a large population inversion in QCLs, efficient injection of electrons into the upper laser level and fast depletion of the lower laser level are essential. In this letter, we focus on the depletion scheme in QCLs and propose an improved active region and injector region structure based on longitudinal optical (LO) phonon scattering, which is known to be the fastest intersubband relaxation process. The first QCL (Ref. 1) was based on a one-phonon depopulation scheme making use of the efficient phonon scattering between two electronic subbands. In this active region design, electrons relax from the lower laser level into the active region ground state by LO-phonon emission. If the energy spacing between the two states is equal to or slightly larger than the LO-phonon energy (E_LO), very short lifetimes (~0.2 ps) for the lower laser level are assumed. However, it was found10,11 that due to the relatively long escape times (~2–3 ps) from the active region into the injector region, electrons accumulate in the active region ground state. This significantly increases the effective lifetime of the lower laser level due to thermally activated backfilling of the electrons from the active region ground state into the lower laser level. Based on these findings, the so-called two-phonon-resonance design was proposed and demonstrated.12 In this design, the enhanced relaxation rate out of the lower laser level is obtained by a ladder of three lower energy states spaced by an optical phonon each in the active region, leading to very short effective lifetimes. The energy separation between the active region ground state and the lower laser level is increased, which decreases thermal backfilling of the electrons from the active region ground state. Since the first demonstration of the two-phonon design, all high performance cw QCLs working at high temperatures were based on this concept.

According to the calculations in Ref. 11, it appears, however, that there are still a non-negligible number of electrons in the lower laser level. Thus, we propose an active region design based on a three-phonon-resonance scheme to more efficiently deplete the lower laser level. We performed simulations based on the rate equation model discussed in Ref. 11, and the results of our calculations show that the ratio between the electron population in the lower laser level and in the upper laser level η is ~0.22 at RT for the proposed three-phonon structure (see Fig. 1) compared to ~0.35 reported for two-phonon designs.11 This can be expressed in the calculation of an effective lower state lifetime τ_l^{\text{eff}} = ητ_u^{\text{eff}}11 where τ_u is the upper laser lifetime. Note that η includes tunneling rates from the lower energy levels of the active region to the energy levels in the injector region. Thus, the effective lower state lifetime for the three-phonon design has a reduced value of 0.14 ps in comparison to 0.23 ps of the two-phonon design based on our calculation. In addition to the more efficient LO-phonon based depletion scheme proposed, four states (levels 4', 3', 2', and 1') from the injector region are designed to couple to the four active region states.

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(levels 4, 3, 2, and 1), respectively, with an average energy splitting of ~9 meV, as shown in Fig. 1. Thus, electrons can resonantly tunnel from all of these lower active region states efficiently into the injector region. The injector design also makes use of resonant LO-phonon scattering to ensure fast relaxation of electrons down to the ground state of the injector, from which electrons are then injected into the upper laser level of the following stage through resonant tunneling. In the proposed three-phonon design, the spacing between the upper laser level (level 5) and the state above (level 6) (~40 meV) is lower than in most other designs (more than 50 meV). According to our rate equation analysis, however, we expect similar injection efficiency into the upper laser level (level 5). The spacing between level 5 and level 6 is only slightly larger than the LO-phonon energy, thus electrons injected into level 6 are quickly (~0.26 ps) scattered into the upper laser level 5.

Although the insertion of energy levels in the active region to increase the number of LO-phonon resonances to efficiently deplete the lower laser level is a straightforward approach, it is limited by other design requirements in QC active regions. The introduction of resonances would shift the upper laser state closer to the continuum increasing leakage paths, which in turn, from which electrons are then injected into the upper laser state closer to the continuum increasing leakage paths, and a vertical transition design, which increases the spatial overlap of the laser transition levels. The calculated upper state lifetime $\tau_5$ and the scattering time from the upper laser level to the lower laser level $\tau_{S4}$ at 300 K are 0.62 and 2.3 ps, respectively, compared to 0.66 and 1.8 ps, respectively, for two-phonon designs. The energy separation between levels 1 and 4 is 116 meV at resonance. The energy separation of $E_i$ (Fig. 2) is important to reduce thermal activated backfilling from the injector ground state. In our structure, $E_i$ is designed to be 153 meV at the resonance condition. The energy separation of $E_k$ (Fig. 1), which is important to suppress carrier leakage into the continuum, is 238 meV in our case in comparison with 244 meV for two-phonon designs at the resonance condition. This parasitic leakage path to the continuum is expected to have the same negative impact on the performance of two-phonon and three-phonon structures since the value of $E_k$ is essentially the same in both designs.

The structure was grown on a n-doped InP substrate ($\sim 3 \times 10^{18}$ cm$^{-3}$), starting with a 3.5 μm thick n-doped (3 $\times$ 10$^{16}$ cm$^{-3}$) InP layer, followed by a 200 nm thick n-doped (3 $\times$ 10$^{16}$ cm$^{-3}$) InGaAs layer, the active region, a 200 nm thick n-doped (3 $\times$ 10$^{16}$ cm$^{-3}$) InGaAs layer, and a top waveguide cladding (consisting of a 3.5 μm thick n-doped (3 $\times$ 10$^{16}$ cm$^{-3}$) InP layer, a 1 μm thick n-doped (3 $\times$ 10$^{16}$ cm$^{-3}$) InP layer, and a thin 20 nm highly n-doped (1 $\times$ 10$^{19}$ cm$^{-3}$) InGaAs contact layer). The active region consists of 40 stages of lattice matched In$_{0.53}$Ga$_{0.47}$As/In$_{0.52}$Al$_{0.48}$As well and barrier layers, grown by MBE. The top InP and InGaAs waveguide layers were grown by MOVPE. The samples were processed into 12, 16, and 20 μm wide buried-heterostructures defined by dry etching. A thick Fe-doped InP layer was regrown by MOVPE. After metallization of the top contacts with Ti/Au, the devices were electroplated with about 10 μm thick Au on the top surface. The wafer was then thinned down to 150 μm, and a Ge/Au (10 nm/200 nm) bottom contact was deposited by e-beam evaporation. Laser bars with different lengths were cleaved and soldered epilayer up on copper submounts with Indium for pulsed operation measurement. Some of the devices were high-reflection (HR) coated on the back facet using Al$_2$O$_3$/Ti/Au (200 nm/10 nm/150 nm) via e-beam evaporation.

Figure 2 shows the light-current-voltage (LIV) characteristics of a HR coated 16 μm wide, 3 mm long device operated in pulsed mode (pulse width 100 ns and 20 kHz repeti-
tion rate) at a heat sink temperature of 300 K. The maximum output power is 1.2 W in pulsed operation with a low threshold current density of 1.1 kA/cm². The slope efficiency of this device is around 1.05 W/A at 300 K, and the measured maximum wall-plug efficiency (WPE) of the device operated in pulsed mode is around 6%. The previously reported QCL (Ref. 13) at λ=9 μm in pulsed operation had a slope efficiency of ~700 mW/A and a WPE of ~3%. High output powers can always be reached by increasing the doping in the active region; however this usually also leads to an increase in threshold current density due to free carrier absorption. It should be noted that our devices still have very low threshold current densities at RT despite their high roll-over current density. Waveguide losses and modal gain coefficient were deduced from the measurements of the threshold current densities of devices with different cavity lengths. Devices with 12 μm wide ridges with different lengths of 2, 3, 4, and 5 mm, without HR coatings, were used. As shown in the inset of Fig. 2, a linear least-squares fit to the measured values gives a modal gain coefficient gΓ of 11.58 cm/kA and a total waveguide loss α₂ of 8.77 cm⁻¹, where g is the gain coefficient and Γ is the optical confinement factor. The experimentally obtained value for the modal gain coefficient is about 20% larger than the ones reported for the two-phonon design in Ref. 5, even though in our case about 20% larger than the ones reported for the two-phonon coefficient and H₂O₂ coefficient and this device is around 1.05 W/A at 300 K, and the measured efficiency of H₂O₂ is 700 mW/A for one facet and the same device operated in pulsed mode with 1% duty cycle has a peak output power of 360 mW for one facet and the measured power was not corrected for an estimated 70% collection efficiency of the setup. The inset shows cw spectra as a function of injection current measured with the same device at a constant temperature of 300 K.

In conclusion, we demonstrated high performance RT H₂O₂ QCLs based on a three-phonon-resonance scheme. It is expected that a better cw performance of the device can be achieved with improved processing, such as adopting a planarized regrown semi-insulating InP layer, and an improved packaging.

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